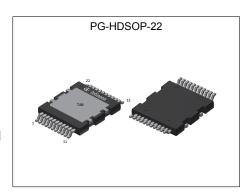


MOSFET

600V CoolMOS™ CM8 Power Transistor

The CoolMOS™ 8th generation platform is a revolutionary technology for high voltage power MOSFETs, designed according to the superjunction (SJ) principle and pioneered by Infineon Technologies. The 600V CoolMOS™ CM8 series is the successor to the CoolMOS™ 7. It combines the benefits of a fast switching SJ MOSFET with excellent ease of use, e.g low ringing tendency, implemented fast body diode (CFD) for all products with outstanding robustness against hard commutation and excellent ESD capability. Furthermore, extremely low switching and conduction losses of CM8, make switching applications even more efficient.



Features

- Suitable for hard and soft switching topologies thanks to an outstanding commutation ruggedness
- Significant reduction of switching and conduction losses
- Best in class R_{DS(on)} per package products enabled by ultra low R_{DS(on)}*A

Benefits

- Ease of use and fast design-in through low ringing tendency and usage across PFC and PWM stages
- Simplified thermal management thanks to our advanced die attach technique
- Increased power density solutions enabled by using products with smaller footprint and higher manufacturing quality due state of the art ESD protection
- Suitable for a wide variety of applications and power ranges

Potential applications

- Power supplies and converters
- PFC stages & LLC resonant converters
- High efficiency switching applications
- e.g. Server, Telecom, EV Charging, UPS

Product validation

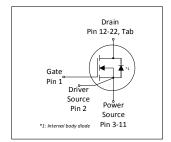
Fully qualified according to JEDEC for Industrial Applications

Please note: For MOSFET paralleling the use of ferrite beads on the gate or separate totem poles is generally recommended.

Table 1 Key Performance Parameters

Table 1 1toy 1 of formation 1 arameters							
Parameter	Value	Unit					
V _{DS} @ T _{j,max}	650	V					
R _{DS(on),max}	7	mΩ					
$Q_{g,typ}$	370	nC					
I _{D,pulse}	1100	А					
E _{oss} @ 400V	49.3	μJ					
Body diode di _F /dt	1300	A/µs					
ESD class (HBM)	2	-					

Type / Ordering Code	Package	Marking	Related Links
IPDQ60R007CM8	PG-HDSOP-22	60R007C8	see Appendix A









600V CoolMOS™ CM8 Power Transistor IPDQ60R007CM8



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600V CoolMOS™ CM8 Power Transistor IPDQ60R007CM8



1 Maximum ratings at $T_j = 25$ °C, unless otherwise specified

Table 2 **Maximum ratings**

Parameter	Values				11	Note / Test Condition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current ¹⁾	I _D	-	-	288 182	А	T _C =25°C T _C =100°C
Pulsed drain current ²⁾	I _{D,pulse}	-	-	1100	Α	T _C =25°C
Avalanche energy, single pulse	E AS	-	-	647	mJ	I _D =10.7A; V _{DD} =50V; see table 10
Avalanche energy, repetitive	E AR	-	-	3.24	mJ	I _D =10.7A; V _{DD} =50V; see table 10
Avalanche current, single pulse	I _{AS}	-	-	10.7	Α	-
MOSFET dv/dt ruggedness	dv/dt	-	-	120	V/ns	V _{DS} =0400V
Gate source voltage (static)	V _{GS}	-20	-	20	V	static;
Gate source voltage (dynamic)	V _{GS}	-30	-	30	V	AC (f>1 Hz)
Power dissipation	P _{tot}	-	-	1249	W	<i>T</i> _C =25°C
Storage temperature	$T_{ m stg}$	-55	-	150	°C	-
Operating junction temperature	T _j	-55	-	150	°C	-
Extended operating junction temperature	T _j	150	-	175	°C	≤50 h in the application lifetime
Mounting torque	-	-	-	-	Ncm	-
Continuous diode forward current	Is	-	-	288	Α	<i>T</i> _C =25°C
Diode pulse current ²⁾	I _{S,pulse}	-	-	1100	Α	<i>T</i> _C =25°C
Reverse diode dv/dt ³⁾	dv/dt	-	-	70	V/ns	$V_{\rm DS}$ =0400V, $I_{\rm SD}$ ≤200A, $T_{\rm j}$ =25°C see table 8
Maximum diode commutation speed	di _F /dt	-	-	1300	A/µs	V _{DS} =0400V, I _{SD} ≤200A, T _j =25°C see table 8
Insulation withstand voltage	V _{ISO}	-	-	n.a.	V	$V_{\rm rms}$, $T_{\rm C}$ =25°C, t =1min

 $^{^{1)}}$ Limited by $T_{j,max}.$ $^{2)}$ Pulse width t_p limited by $T_{j,max}$ $^{3)}$ Identical low side and high side switch with identical $R_{\rm G}$

600V CoolMOS™ CM8 Power Transistor IPDQ60R007CM8



2 Thermal characteristics

Table 3 Thermal characteristics

Davamatav	Cumbal	Values			11	Note / Took Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Thermal resistance, junction - case	R _{thJC}	-	-	0.1	K/W	-
Thermal resistance, junction - ambient	R _{thJA}	-	-	62	K/W	device on PCB, minimal footprint
Thermal resistance, junction - ambient for SMD version	NthJA	-	45	55	K/W	Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70µm thickness) copper area. Tap exposed to air. PCB is vertical without air stream cooling.
Soldering temperature, reflow soldering allowed	T _{sold}	_	-	260	°C	reflow MSL1

600V CoolMOS™ CM8 Power Transistor

IPDQ60R007CM8



3 Electrical characteristics at T_j =25°C, unless otherwise specified

Table 4 **Static characteristics**

Parameter	Ol		Values			Nata / Task Oamskillan
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V _{(BR)DSS}	600	-	-	V	V_{GS} =0V, I_D =1mA
Gate threshold voltage	$V_{(GS)th}$	3.7	4.2	4.7	V	$V_{\rm DS}=V_{\rm GS},\ I_{\rm D}=3.24{\rm mA}$
Zero gate voltage drain current	I _{DSS}	-	- 976	4 -	μΑ	V _{DS} =600V, V _{GS} =0V, T _j =25°C V _{DS} =600V, V _{GS} =0V, T _j =150°C
Gate-source leakage current	I _{GSS}	-	-	0.1	μA	V _{GS} =20V, V _{DS} =0V
Drain-source on-state resistance	R _{DS(on)}	-	0.006 0.013	0.007	Ω	V _{GS} =10V, I _D =100A, T _j =25°C V _{GS} =10V, I _D =100A, T _j =150°C
Gate resistance	R _G	-	1	-	Ω	f=1MHz

Table 5 **Dynamic characteristics**

Parameter	Oh a l	Values			1114		
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Input capacitance	C _{iss}	-	16385	-	pF	V _{GS} =0V, V _{DS} =400V, f=250kHz	
Output capacitance	Coss	-	192	-	pF	V _{GS} =0V, V _{DS} =400V, f=250kHz	
Effective output capacitance, energy related ¹⁾	C _{o(er)}	-	617	-	pF	V _{GS} =0V, V _{DS} =0400V	
Effective output capacitance, time related ²⁾	C _{o(tr)}	-	6440	-	pF	I_D =constant, V_{GS} =0V, V_{DS} =0400V	
Turn-on delay time	t _{d(on)}	-	49.5	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =64.7A, $R_{\rm G}$ =1.8 Ω ; see table 9	
Rise time	t _r	-	16.5	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =64.7A, $R_{\rm G}$ =1.8 Ω ; see table 9	
Turn-off delay time	$t_{ m d(off)}$	-	215.2	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =64.7A, $R_{\rm G}$ =1.8 Ω ; see table 9	
Fall time	t _f	-	8.4	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =64.7A, $R_{\rm G}$ =1.8 Ω ; see table 9	

Table 6 **Gate charge characteristics**

Parameter	Cumbal	Values			11:4	Note / Test Condition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q _{gs}	-	98	-	nC	V_{DD} =400V, I_{D} =64.7A, V_{GS} =0 to 10V
Gate to drain charge	Q _{gd}	-	131	-	nC	V_{DD} =400V, I_{D} =64.7A, V_{GS} =0 to 10V
Gate charge total	Qg	-	370	-	nC	V_{DD} =400V, I_{D} =64.7A, V_{GS} =0 to 10V
Gate plateau voltage	V _{plateau}	-	5.9	-	V	V_{DD} =400V, I_{D} =64.7A, V_{GS} =0 to 10V

 $^{^{1)}}$ $C_{\text{o(er)}}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 400V $^{2)}$ $C_{\text{o(tr)}}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 400V

600V CoolMOS™ CM8 Power Transistor

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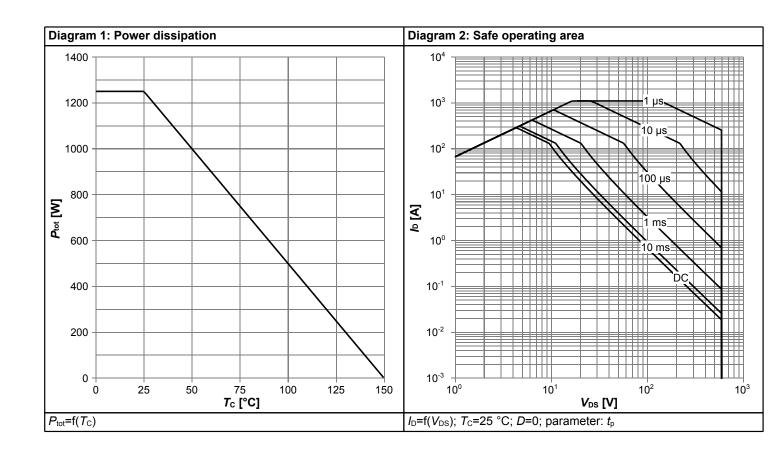


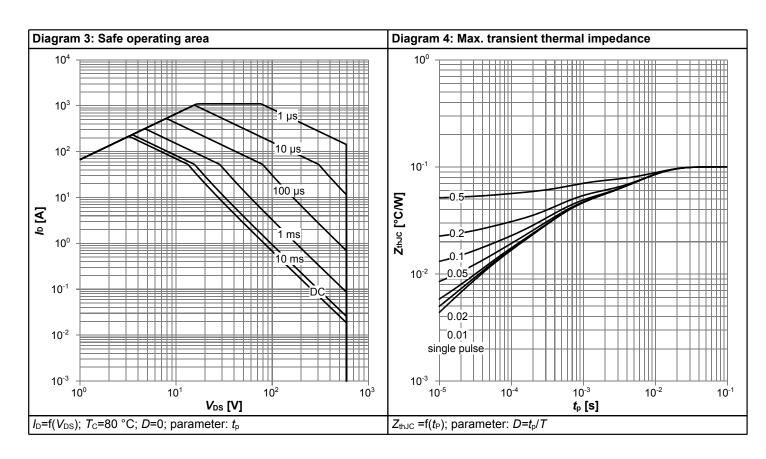
Table 7 Reverse diode characteristics

Parameter	Cymphal	Values			11	Nata / Tast Candition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Diode forward voltage	V _{SD}	-	0.9	-	V	V _{GS} =0V, I _F =64.7A, T _j =25°C
Reverse recovery time	t _{rr}	-	280	350	ns	V_R =400V, I_F =64.7A, di_F/dt =100A/ μ s; see table 8
Reverse recovery charge	Q _{rr}	-	3.30	4.95	μC	V_R =400V, I_F =64.7A, di_F/dt =100A/ μ s; see table 8
Peak reverse recovery current	I _{rrm}	-	18.0	-	А	V_R =400V, I_F =64.7A, di_F/dt =100A/ μ s; see table 8

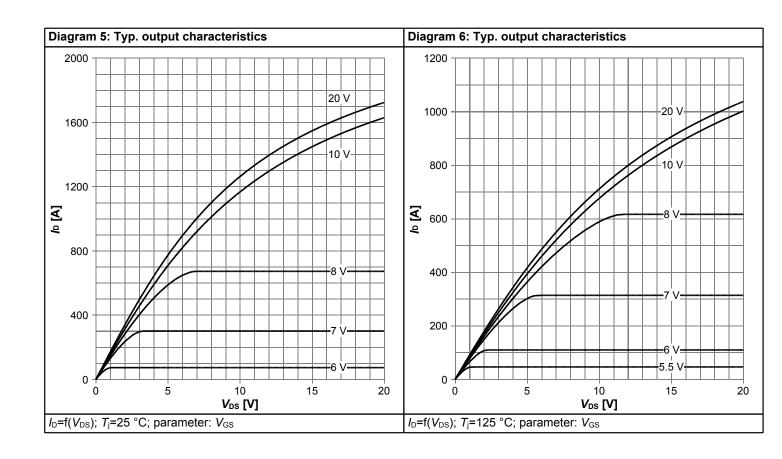


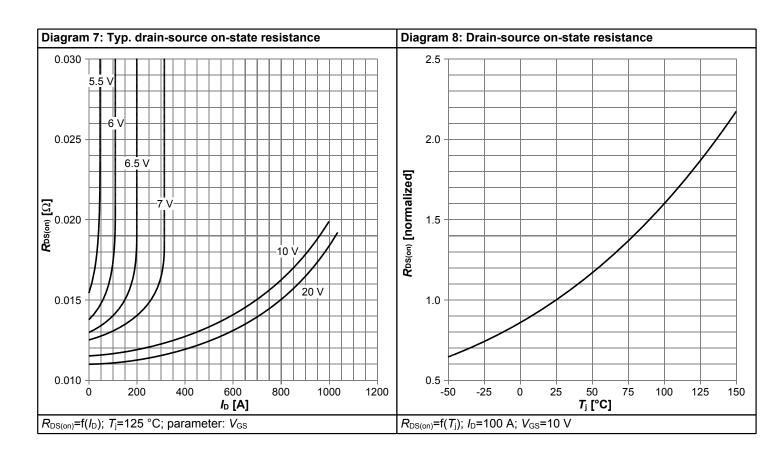
4 Electrical characteristics diagrams



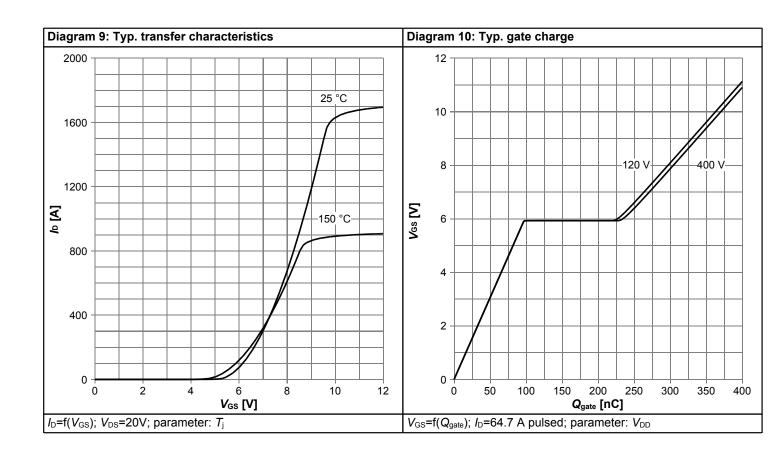


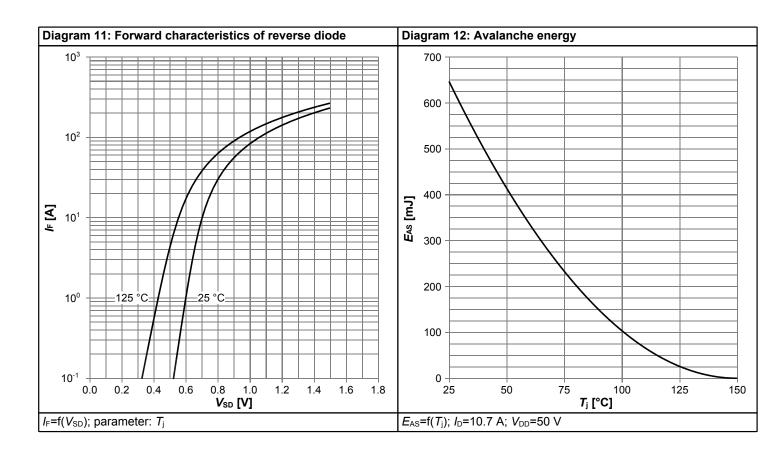




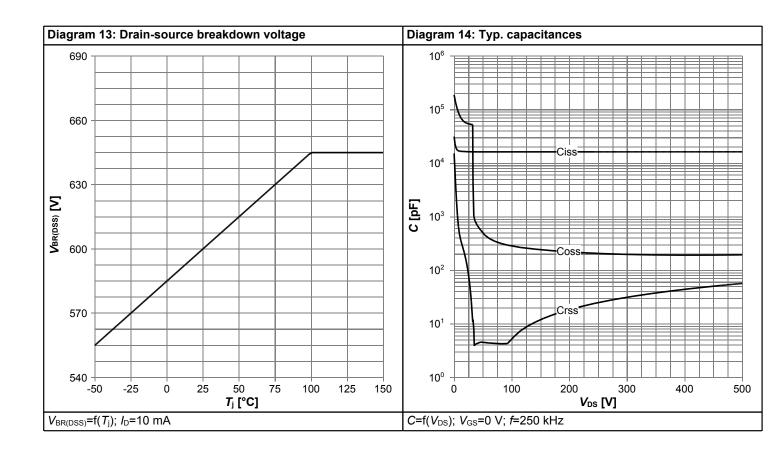


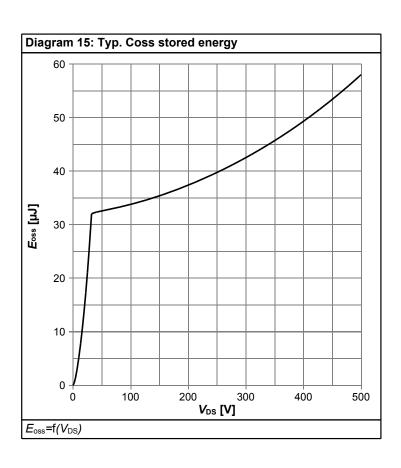














5 Test Circuits

Table 8 Diode characteristics

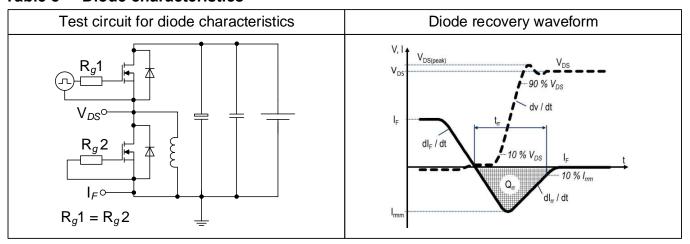


Table 9 Switching times (ss)

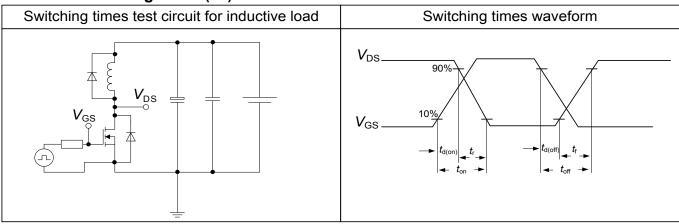
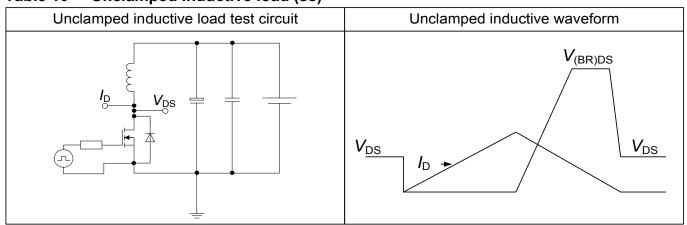


Table 10 Unclamped inductive load (ss)





6 Package Outlines

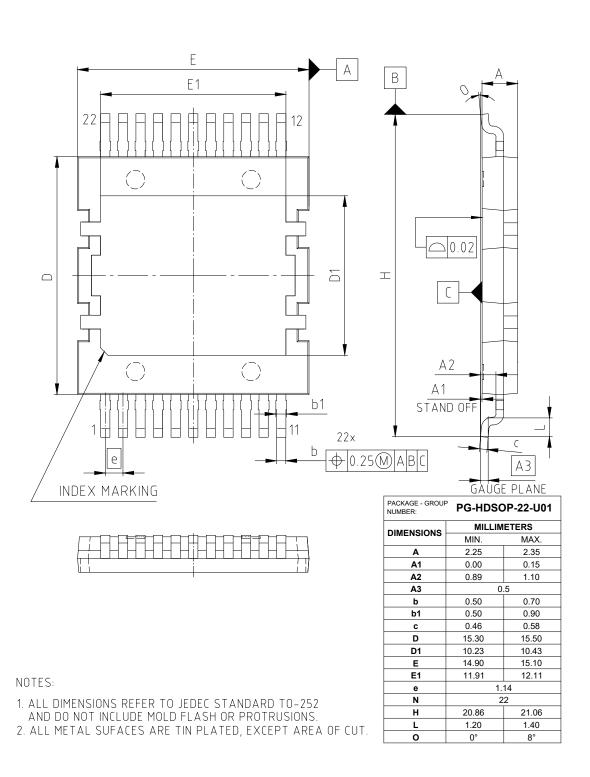


Figure 1 Outline PG-HDSOP-22, dimensions in mm

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600V CoolMOS™ CM8 Power Transistor IPDQ60R007CM8



7 Appendix A

Table 11 Related Links

• IFX CoolMOS CM8 Webpage: www.infineon.com

• IFX CoolMOS CM8 application note: www.infineon.com

• IFX CoolMOS CM8 simulation model: www.infineon.com

• IFX Design tools: www.infineon.com

600V CoolMOS™ CM8 Power Transistor

IPDQ60R007CM8



Revision History

IPDQ60R007CM8

Revision: 2024-03-21, Rev. 2.1

Previous Revision

1 10110401	1 Tovious Novision							
Revision	Date	Subjects (major changes since last revision)						
2.0	2023-09-26	Release of final version						
2.1	2024-03-21	Update of R _{thJC}						

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